

<b>Notice of References Cited</b>	Application/Control No. 10/780,662	Applicant(s)/Patent Under Reexamination BUTKUS ET AL.	
	Examiner Betsey M Hoey	Art Unit 1724	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,236,595	08-1993	Wang et al.	210/669
	B	US-6,156,210	12-2000	Sadkhin, Grigory	210/709
	C	US-6,607,668	08-2003	Rela, Matthew	210/321.6
	D	US-5,342,528	08-1994	Adachi et al.	210/668
	E	US-6,267,895	07-2001	Engelhard et al.	210/748
	F	US-6,602,425	08-2003	Gadgil et al.	210/744
	G	US-6,495,052	12-2002	Miyamoto et al.	210/764
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.